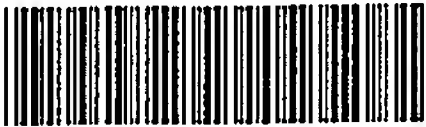


<b>Search Notes</b>  	<b>Application/Control No.</b>  10711213	<b>Applicant(s)/Patent Under Reexamination</b>  YANG ET AL.
	<b>Examiner</b>  Sim, Yong	<b>Art Unit</b>  2635

SEARCHED			
Class	Subclass	Date	Examiner
345	173	12/07/2006	Yong Sim
349	12	12/07/2006	Yong Sim

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted SPE Vu Le to clarify the claim language. Electrode layers disclosed in the prior art is construed as a detetion circuit.	12/08/2006	Yong Sim
Conducted double patenting search on EAST and eDAN	12/08/2006	Yong Sim

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner